
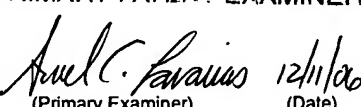
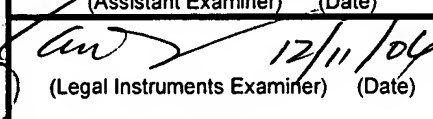


<b>Issue Classification</b> 	<b>Application/Control No.</b> 10/538,825	<b>Applicant(s)/Patent under Reexamination</b> YE, CHUN
	<b>Examiner</b> Derek S. Chapel	<b>Art Unit</b> 2872

ISSUE CLASSIFICATION												
ORIGINAL					INTERNATIONAL CLASSIFICATION							
CLASS		SUBCLASS			CLAIMED				NON-CLAIMED			
359		501			G	02	B	5	/30			/
CROSS REFERENCES												
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)											
359	498	497							/			/
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Derek S. Chapel 12/8/2006 (Assistant Examiner) (Date)	<b>ARNEL LAVARIAS</b> <b>PRIMARY PATENT EXAMINER</b>  12/11/06 (Primary Examiner) (Date)	<b>Total Claims Allowed: 65</b>
 12/11/06 (Legal Instruments Examiner) (Date)	O.G. Print Claim(s) 6	O.G. Print Fig. 11

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant						<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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